

Search Notes

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PAUL T. CHIN

Applicant(s)/Patent under
Reexamination

FRANZEN ET AL.

Art Unit

3652

SEARCHED

Class	Subclass	Date	Examiner
294	81.4, 81.5	8/27/2007	PTC
294	81.3	8/27/2007	PTC
212	73, 204		
	342	8/28/2007	PTC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR